BUK964R2-80E



N-channel TrenchMOS logic level FET Rev. 2 — 16 May 2012

Product data sheet

1. **Product profile**

1.1 General description

Logic level N-channel MOSFET in a SOT404 package using TrenchMOS technology. This product has been designed and qualified to AEC Q101 standard for use in high performance automotive applications.

1.2 Features and benefits

- AEC Q101 compliant
- Repetitive avalanche rated
- Suitable for thermally demanding environments due to 175 °C rating
- True logic level gate with Vgst(th) rating of greater than 0.5V at 175 ℃

1.3 Applications

- 12V, 24V and 48V Automotive systems
- Motors, lamps and solenoid control
- Start-Stop micro-hybrid applications
- Transmission control
- Ultra high performance power switching

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 ^{\circ}\text{C}; T_j \le 175 ^{\circ}\text{C}$	-	-	80	V
I_D	drain current	$V_{GS} = 5 \text{ V}; T_{mb} = 25 \text{ °C}; T_{mb} = 25 \text{ °C};$ see Figure 1	[1] -	-	120	Α
P _{tot}	total power dissipation	T _{mb} = 25 ℃; see <u>Figure 2</u>	-	-	357	W
Static characte	Static characteristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$ see Figure 11	-	3.4	4.2	mΩ
Dynamic chara	Dynamic characteristics					
Q_{GD}	gate-drain charge	$V_{GS} = 5 \text{ V}$; $I_D = 25 \text{ A}$; $V_{DS} = 64 \text{ V}$; see <u>Figure 13</u> ; see <u>Figure 14</u>	-	37.5	-	nC

^[1] Continuous current is limited by package.



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	D	drain	mb	D
3	S	source		G (EX)
mb	D	mounting base; connected to drain	1 3	mbb076 S
			SOT404 (D2PAK)	

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK964R2-80E	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

4. Marking

Table 4. Marking codes

Type number	Marking code
BUK964R2-80E	BUK964R2-80E

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 ^{\circ}C; T_j \le 175 ^{\circ}C$	-	80	V
V_{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	80	V
V_{GS}	gate-source voltage	DC	-10	10	V
		Pulsed	-15	15	V
I _D	drain current	T_{mb} = 25 °C; T_{mb} = 25 °C; V_{GS} = 5 V; see Figure 1	<u>[1]</u> -	120	Α
		$T_{mb} = 100 \text{C}; V_{GS} = 5 \text{ V}; \text{ see } \underline{\text{Figure 1}}$	[1] -	120	Α
I _{DM}	peak drain current	$T_{mb} = 25$ °C; pulsed; $t_p \le 10 \mu s$; see Figure 4	-	740	Α
P _{tot}	total power dissipation	T _{mb} = 25 ℃; see <u>Figure 2</u>	-	357	W
T _{stg}	storage temperature		-55	175	℃
T _j	junction temperature		-55	175	℃
Source-drain	diode				
Is	source current	T _{mb} = 25 ℃	[1] -	120	Α
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$	-	740	Α
Avalanche ru	ggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	I_D = 120 A; V_{sup} ≤ 80 V; R_{GS} = 50 Ω; V_{GS} = 5 V; $T_{j(init)}$ = 25 °C; unclamped; see Figure 3	[2][3] -	485	mJ

^[1] Continuous current is limited by package.

^[2] Single-pulse avalanche rating limited by maximum junction temperature of 175 $^{\circ}\!\text{C}.$

^[3] Refer to application note AN10273 for further information.

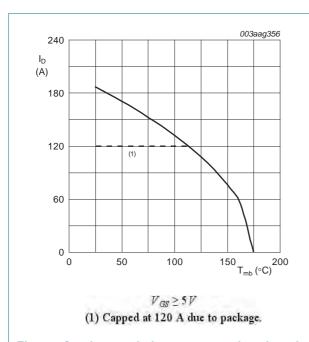


Fig 1. Continuous drain current as a function of mounting base temperature

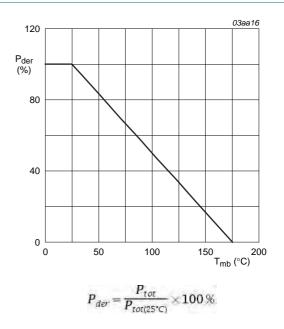
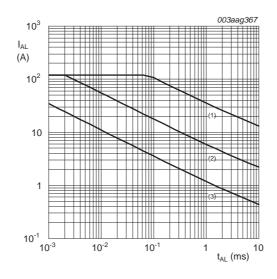


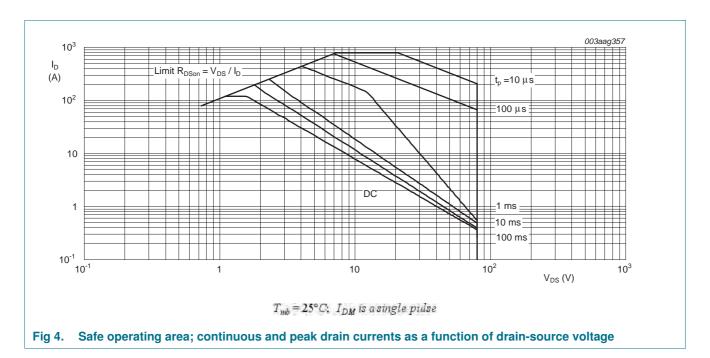
Fig 2. Normalized total power dissipation as a function of mounting base temperature



(1) $T_{j (jnt)} = 25^{\circ}C$; (2) $T_{j (jnt)} = 150^{\circ}C$; (3) Repetitive Avalanche

Fig 3. Single-pulse and repetitive avalanche rating; avalanche current as a function of avalanche time

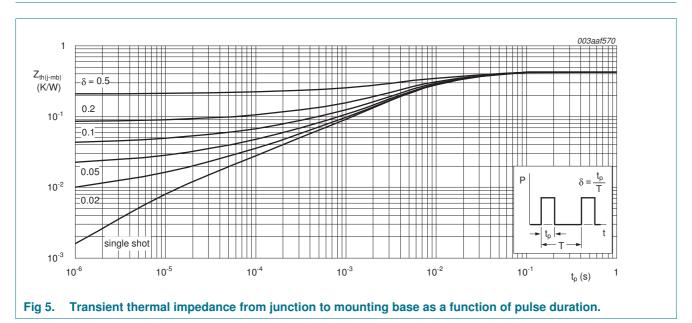
4 of 14



6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j\text{-}mb)}$	thermal resistance from junction to mounting base	see <u>Figure 5</u>	-	-	0.42	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	minimum footprint; mounted on a printed-circuit board	-	50	-	K/W



7. Characteristics

Table 7. Characteristics

Table 7.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
$V_{(BR)DSS}$	drain-source	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 ^{\circ}C$	80	-	-	V
	breakdown voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^{\circ}C$	72	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 25 \text{ °C}$; see <u>Figure 9</u> ; see <u>Figure 10</u>	1.4	1.7	2.1	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = -55 \text{ °C}$; see Figure 9	-	-	2.45	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 175 \text{ °C}$; see Figure 9	0.5	-	-	V
I _{DSS}	drain leakage current	$V_{DS} = 80 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	0.08	1	μΑ
		$V_{DS} = 80 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 ^{\circ}\text{C}$	-	-	500	μΑ
I _{GSS}	gate leakage current	$V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	2	100	nΑ
		$V_{GS} = -10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	2	100	nA
R_{DSon}	drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$ see Figure 11	-	3.4	4.2	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$ see Figure 11	-	3.2	4	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see Figure 12; see Figure 11	-	-	10.4	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 64 \text{ V}; V_{GS} = 5 \text{ V};$	-	123	-	nC
Q_{GS}	gate-source charge	see Figure 13; see Figure 14	-	26.6	-	nC
Q_{GD}	gate-drain charge		-	37.5	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	12850	17130	рF
C _{oss}	output capacitance	T _j = 25 ℃; see <u>Figure 15</u>	-	850	1020	рF
C_{rss}	reverse transfer capacitance		-	420	580	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 60 \text{ V}; R_L = 2.4 \Omega; V_{GS} = 5 \text{ V};$	-	70	-	ns
t _r	rise time	$R_{G(ext)} = 5 \Omega$	-	109	-	ns
t _{d(off)}	turn-off delay time		-	203	-	ns
t _f	fall time		-	115	-	ns
L _D	internal drain inductance	from upper edge of drain mounting base to center of die	-	2.5	-	nΗ
L _S	internal source inductance	from source lead to source bonding pad	-	7.5	-	nΗ
Source-d	rain diode					
V_{SD}	source-drain voltage	$I_S = 25 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ °C}$; see Figure 16	-	0.77	1.2	V
t _{rr}	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$	-	61	-	ns
Q _r	recovered charge	$V_{DS} = 25 \text{ V}$		139		nC

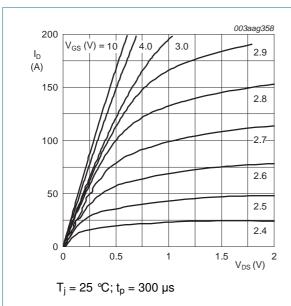


Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values

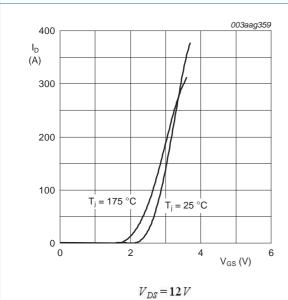


Fig 8. Transfer characteristics: drain current as a function of gate-source voltage; typical values

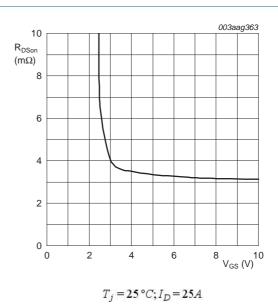


Fig 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

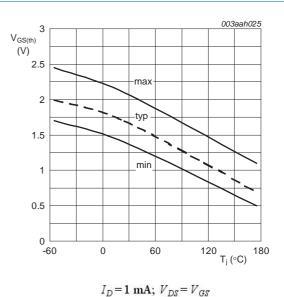


Fig 9. Gate-source threshold voltage as a function of junction temperature

7 of 14

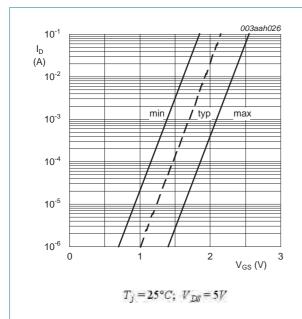


Fig 10. Sub-threshold drain current as a function of gate-source voltage

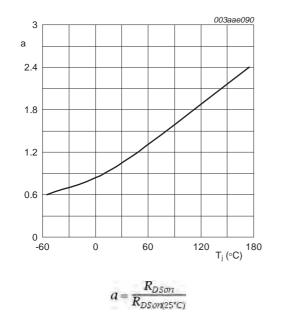


Fig 12. Normalized drain-source on-state resistance factor as a function of junction temperature

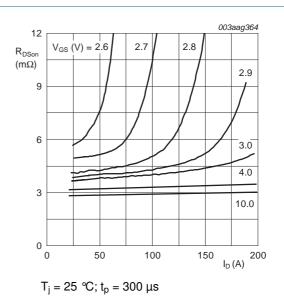


Fig 11. Drain-source on-state resistance as a function of drain current; typical values

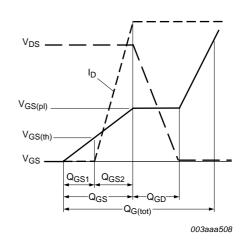


Fig 13. Gate charge waveform definitions

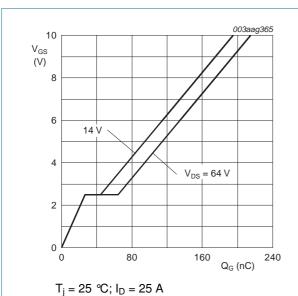
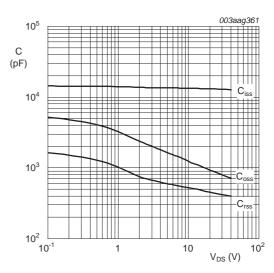
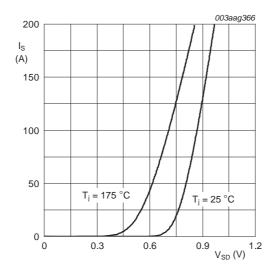


Fig 14. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0 V$; f = 1 MHz

Fig 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



 $V_{GS} = 0 V$

Fig 16. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

8. Package outline

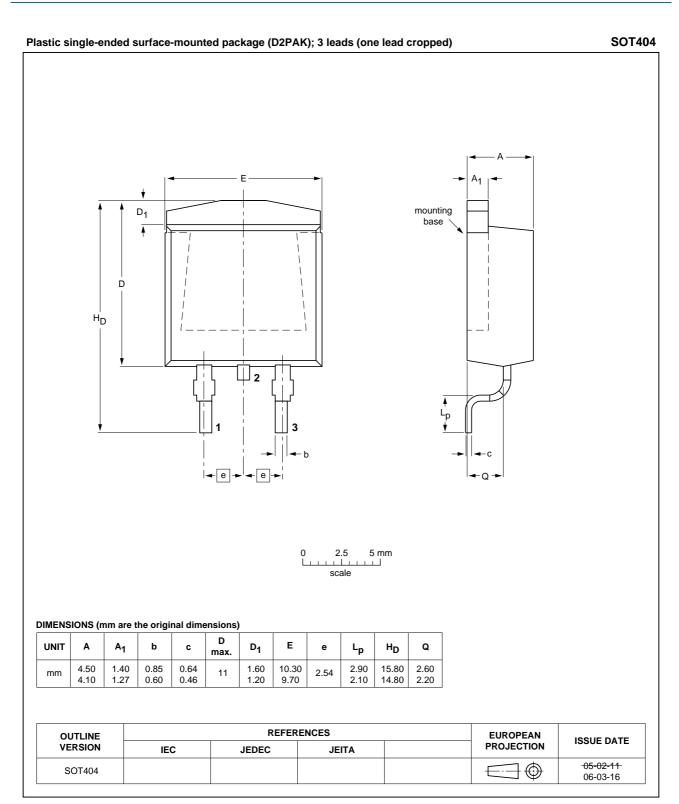


Fig 17. Package outline SOT404 (D2PAK)

Revision history

Table 8. **Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK964R2-80E v.2	20120516	Product data sheet	-	BUK964R2-80E v.1
Modifications:	Status changeVarious chang	d from objective to product. es to content.		
BUK964R2-80E v.1	20120404	Objective data sheet	-	-

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Document status[1] [2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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12. Contents

1	Product profile	.1
1.1	General description	.1
1.2	Features and benefits	
1.3	Applications	.1
1.4	Quick reference data	.1
2	Pinning information	.2
3	Ordering information	.2
4	Marking	.2
5	Limiting values	.3
6	Thermal characteristics	
7	Characteristics	
8	Package outline	
9	Revision history	
10	Legal information	
10.1	Data sheet status	
10.2	Definitions	
10.3	Disclaimers	
10.4	Trademarks	
11	Contact information	

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